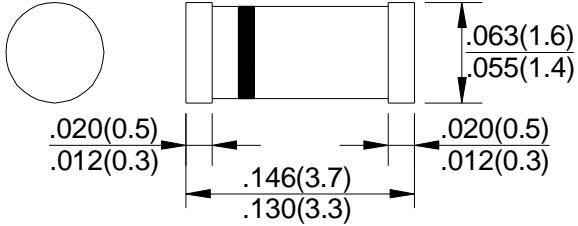


<b>SMALL SIGNAL SWITCHING DIODE</b>	<b>REVERSE VOLTAGE - 75 Volts</b> <b>FORWARD CURRENT - 0.15Amperes</b>
<b>FEATURES</b> <ul style="list-style-type: none"> <li>● Silicon epitaxial planar diode</li> <li>● High speed switching diode</li> <li>● 500mW power dissipation</li> </ul>	<div style="border: 1px solid black; padding: 2px; margin: 0 auto; width: 80px;"> <b>DL - 35</b> </div> 
<b>MECHANICAL DATA</b> <ul style="list-style-type: none"> <li>● Case: Mini-MELF glass case</li> <li>● Polarity: Color band denotes cathode</li> <li>● Weight : Approx.0.05 grams</li> </ul>	Dimensions in inches and (millimeters)

**MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS**

Rating at 25°C ambient temperature unless otherwise specified.

**MAXIMUM RATINGS**

		LL4148	UNIT
Reverse Voltage	V <sub>R</sub>	75	V
Peak Reverse Voltage	V <sub>RM</sub>	100	V
Average Forward Rectified Current Half Wave Rectification with Resist .load at T <sub>amb</sub> =25°C and f ≧ 50Hz	I <sub>O</sub>	150	mA
Forward Surge Current at t<1s and T <sub>J</sub> =25°C	I <sub>FSM</sub>	500	mA
Power Dissipation at T <sub>amb</sub> =25°C	P <sub>tot</sub>	500 <sup>(1)</sup>	mW
Junction Temperature	T <sub>J</sub>	175	°C
Storage Temperature Range	T <sub>STG</sub>	- 65 to + 175	°C

NOTE:(1) Valid provided that electrodes are kept at ambient temperature .

**ELECTRICAL CHARACTERISTICS**

		MIN	TYP	MAX	UNIT
Forward Voltage at I <sub>F</sub> =10mA	V <sub>F</sub>	-	-	1	V
Leakage Current at V <sub>R</sub> =20V at V <sub>R</sub> =75V at V <sub>R</sub> =20V T <sub>J</sub> =150°C	I <sub>R</sub>	-	-	25	nA
	I <sub>R</sub>	-	-	5	uA
	I <sub>R</sub>	-	-	50	uA
Capacitance at V <sub>F</sub> =V <sub>R</sub> =0V	C <sub>tot</sub>	-	-	4	pF
Voltage Rise When Switching ON Tested With 50mA Pulses tp=0.1us.Rise Time<30ns.fp=5to 100Hz	V <sub>fr</sub>	-	-	2.5	v
Reverse Recovery Time From I <sub>F</sub> =10mA V <sub>R</sub> =6V. RL=100Ω at I <sub>R</sub> =1mA	t <sub>rr</sub>	-	-	4	ns
Thermal Resistance Junction to Ambient	R <sub>θJA</sub>	-	-	350 <sup>(1)</sup>	°C/W
Rectification Efficiency at 100MHZ V <sub>RF</sub> =2V	η <sub>V</sub>	0.45	-	-	-

NOTE:(1)Valid provided that electrodes are kept at ambient temperature.

LL4148

FIG.1-ADMISSIBLE POWER DISSIPATION  
VERSUS AMBIENT TEMPERATURE

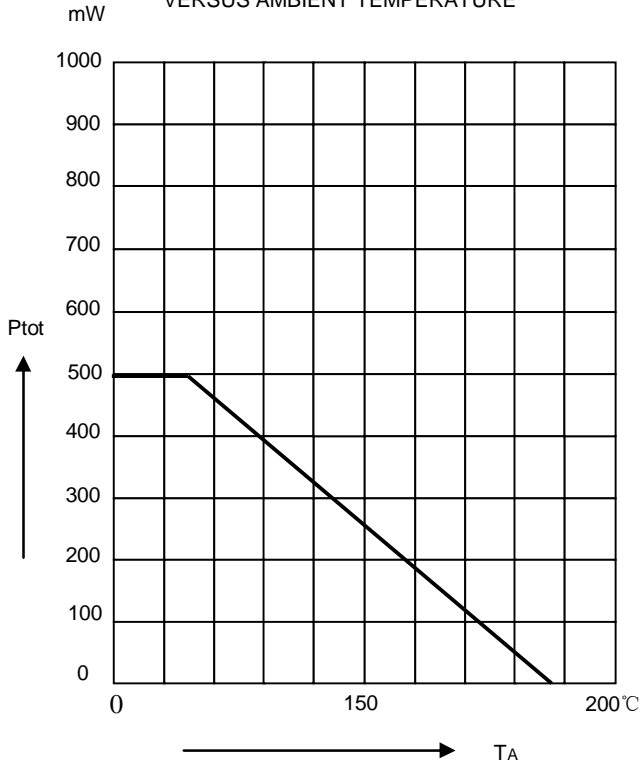


FIG.2-FORWARD CHARACTERISTICS

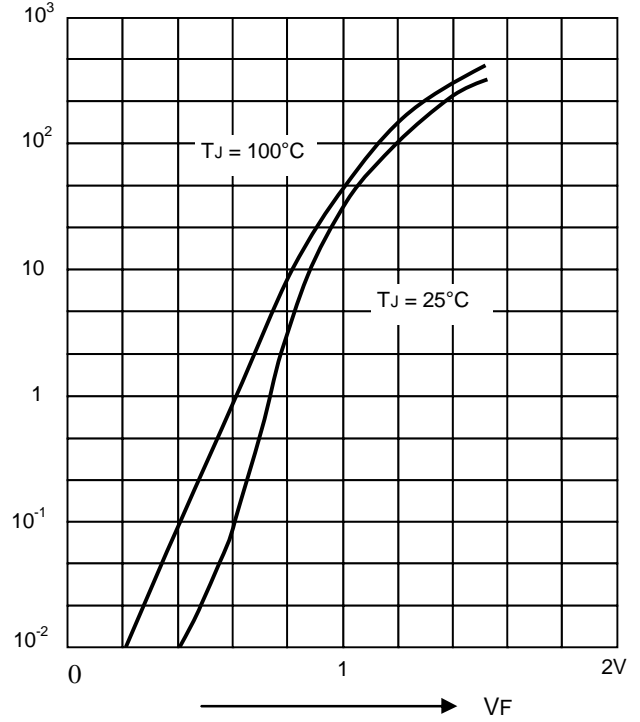


FIG.3-ADMISSIBLE REPETITIVE PEAK FORWARD CURRENT VERSUS PULSE DURATION

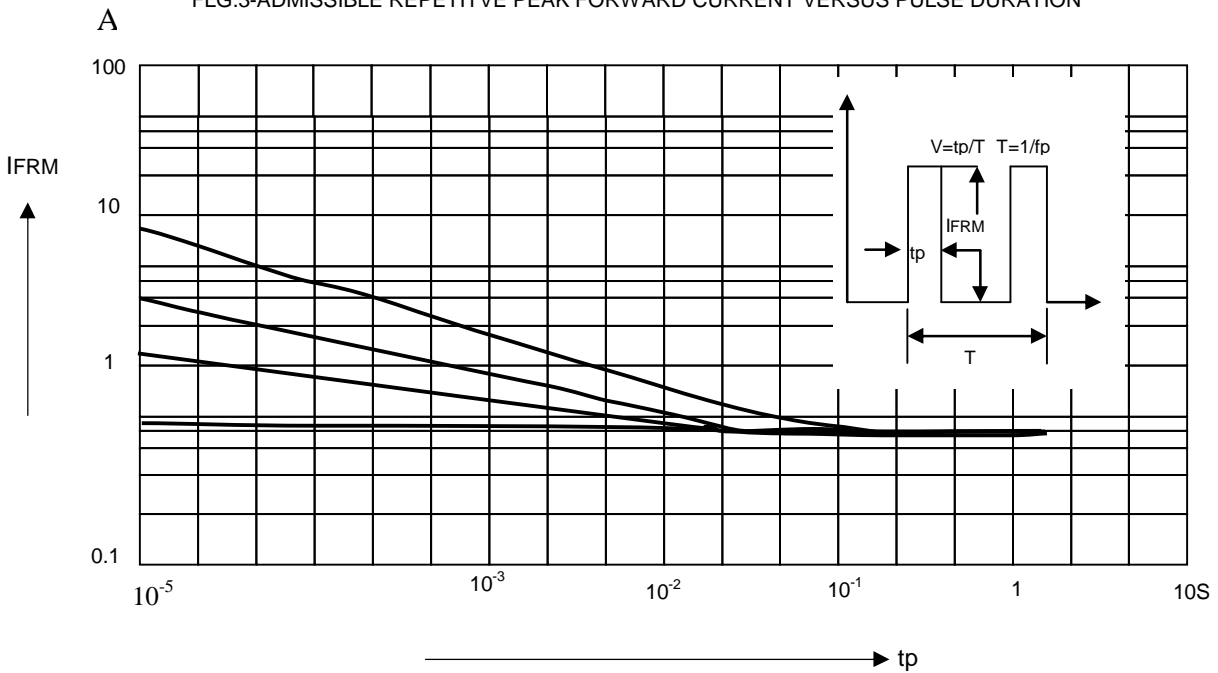


FIG.4-RECTIFICATION EFFICIENCY MEASUREMENT CIRCUIT

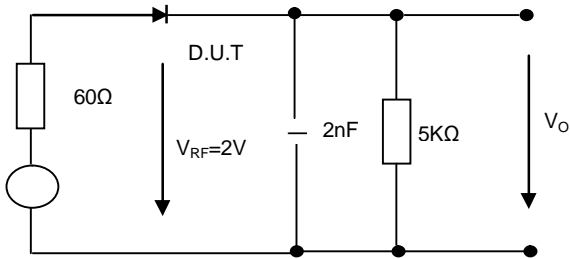


FIG.5-RELATIVE CAPACITANCE VERSUS VOLTAGE

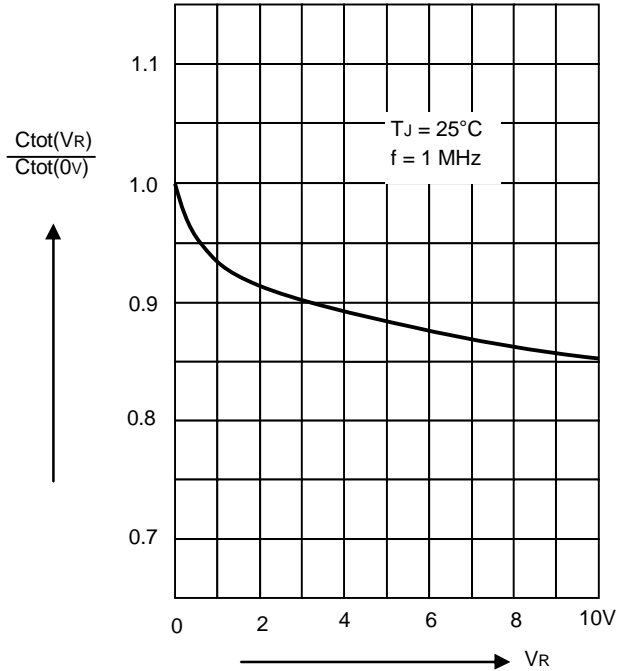


FIG.6-LEAKAGE CURRENT VERSUS JUNCTION TEMPERATURE

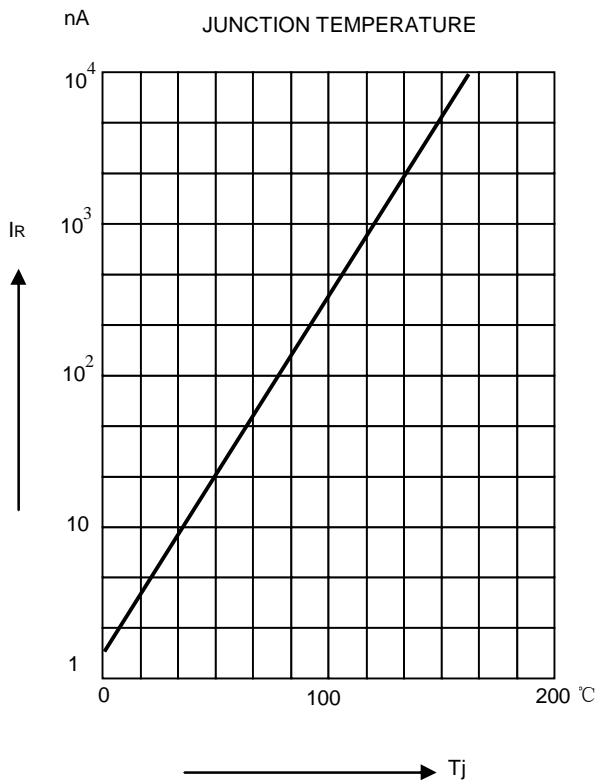


FIG.7-DYNAMIC FORWARD RESISTANCE VERSUS FORWARD CURRENT

